Search Notes

Application/Control No.	Applic Reexa
10/714,524	DEMII
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Ellen Kim

Applicant(s)/Patent under Reexamination

DEMIDOV ET AL.

Art Unit

2874

SEARCHED					
385	37	3/1/2007	EK		
372	3,6	3/1/2007	EK		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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